

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/562,769	HEYWOOD ET AL.
	Examiner	Art Unit
	David J. Blanchard	1643

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
SEQ ID Nos.1-14 and 16-20		5/14/2008	DB

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STIC search SEQ ID Nos:1-10 (results in SCORE)	5/14/2009	DB
STIC search SEQ ID Nos:11-14 and 16-20 (results in SCORE)	5/14/2009	DB
WEST, STN - medline, embase, esbiodbase, scisearch, lifesci, biosis, biotecho, dissabs, inventor search (see notes)	5/14/2009	DB